

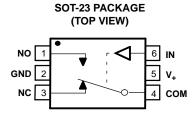
### **FEATURES**

- Controlled Baseline
  - One Assembly/Test Site, One Fabrication Site
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree (1)
- Specified Break-Before-Make Switching
- Low ON-State Resistance (1  $\Omega$ )
- Control Inputs Are 5-V Tolerant
- Low Charge Injection
- Excellent ON-State Resistance Matching
- (1) Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not liited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- Low Total Harmonic Distortion
- 1.65-V to 5.5-V Single-Supply Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)

### **APPLICATIONS**

- Cell Phones
- PDAs
- Portable Instrumentation



### **DESCRIPTION/ORDERING INFORMATION**

The TS5A3159-EP is a single-pole double-throw (SPDT) analog switch that is designed to operate from 1.65 V to 5.5 V. The device offers a low ON-state resistance and an excellent ON-state resistance matching with the break-before-make feature to prevent signal distortion during the transferring of a signal from one channel to another. The device has excellent total harmonic distortion (THD) performance and consumes very low power. These features make this device suitable for portable audio applications.

### Summary of Characteristics(1)

Configuration	2:1 Multiplexer/ Demultiplexer (1 × SPDT)
Number of channels	1
ON-state resistance (r <sub>on</sub> )	1.1 Ω
ON-state resistance match (Δr <sub>on</sub> )	0.1 Ω
ON-state resistance flatness (r <sub>on(flat)</sub> )	0.15 Ω
Turn-on/turn-off time (t <sub>ON</sub> /t <sub>OFF</sub> )	20 ns/15 ns
Break-before-make time (t <sub>BBM</sub> )	12 ns
Charge injection (Q <sub>C</sub> )	36 pC
Bandwidth (BW)	100 MHz
OFF isolation (O <sub>ISO</sub> )	-65 dB at 1 MHz
Crosstalk (X <sub>TALK</sub> )	-66 dB at 1 MHz
Total harmonic distortion (THD)	0.01%
Leakage current (I <sub>NO(OFF)</sub> /(I <sub>NC(OFF)</sub> )	±20 nA
Package option	6-pin DBV

(1)  $V_+ = 5 \text{ V} \text{ and } T_A = 25^{\circ}\text{C}$ 



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



### **ORDERING INFORMATION**

T <sub>A</sub>	PACKAG	SE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING		
–55°C to 125°C	SOT (SOT-23) - DBV	Tape and reel	TS5A3159MDBVREP	JA8R		

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

### **FUNCTION TABLE**

IN	NC TO COM, COM TO NC	NO TO COM, COM TO NO
L	ON	OFF
Н	OFF	ON

## Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>+</sub>	Supply voltage range <sup>(2)</sup>		-0.5	6.5	V
$V_{NO} \ V_{COM}$	Analog voltage range <sup>(2)(3)(4)</sup>		-0.5	V <sub>+</sub> + 0.5	V
I <sub>I/OK</sub>	Analog port diode current	$V_{NO}$ , $V_{COM} < 0$ or $V_{NO}$ , $V_{COM} > V_{+}$		±50	mA
$I_{NO}$ $I_{COM}$	On-state switch current	$V_{NO}$ , $V_{COM} = 0$ to $V_{+}$		±200	mA
	On-state peak switch current <sup>(5)</sup>			±400	mA
$V_{IN}$	Digital input voltage range(2)(3)		-0.5	6.5	V
I <sub>IK</sub>	Digital input clamp current	V <sub>IN</sub> < 0		-50	mA
	Continuous current through V <sub>+</sub> or GND			±100	mA
$\theta_{JA}$	Package thermal impedance (6)			165	°C/W
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "Electrical Characteristics" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to ground, unless otherwise specified.

<sup>(3)</sup> The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>(4)</sup> This value is limited to 5.5 V maximum.

<sup>(5)</sup> Pulse at 1-ms duration < 10% duty cycle.

<sup>(6)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.



# **Electrical Characteristics for 5-V Supply**

 $V_{+} = 4.5 \text{ V to } 5.5 \text{ V (5 V nominal)}, T_{A} = -55^{\circ}\text{C to } 125^{\circ}\text{C} \text{ (unless otherwise noted)}$ 

PARAMETER	SYMBOL	TEST CONDI	TIONS	T <sub>A</sub>	V <sub>+</sub>	MIN T	YP <sup>(1)</sup>	MAX	UNIT
<b>Analog Switch</b>									
Analog signal range	$V_{COM}$ , $V_{NC}$ , $V_{NO}$					0		V <sub>+</sub>	V
Peak ON	r	$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,	Switch ON,	25°C	4.5 V		1	1.5	Ω
resistance	r <sub>peak</sub>	$I_{COM} = -30 \text{ mA},$	See Figure 11	Full	4.5 V			1.5	52
ON-state	r	$V_{NO}$ or $V_{NC} = 2.5 \text{ V}$ ,	Switch ON,	25°C	4.5 V		0.75	1.1	Ω
resistance	r <sub>on</sub>	$I_{COM} = -30 \text{ mA},$	See Figure 11	Full	7.5 V			1.3	32
ON-state resistance match between channels	$\Delta {\sf r}_{\sf on}$	$V_{NO}$ or $V_{NC}$ = 2.5 V, $I_{COM}$ = -30 mA,	Switch ON, See Figure 11	25°C	4.5 V		0.1		Ω
ON-state		$0 \le V_{NO}$ or $V_{NC} \le V_+$ , $I_{COM} = -30 \text{ mA}$	Switch ON,		4.5 V	(	0.233		Ω
resistance flatness	r <sub>on(flat)</sub>	$V_{NO}$ or $V_{NC} = 1 \text{ V}$ , 1.5 V, 2.5 V, $I_{COM} = -30 \text{ mA}$	See Figure 11	25°C			0.15		
NC, NO	I <sub>NC(OFF)</sub> ,	$V_{NC}$ or $V_{NO} = 4.5 \text{ V}$ ,	Switch OFF,	25°C		-6	0.2	4	nA
OFF leakage current	I <sub>NO(OFF)</sub>	$V_{COM} = 0,$	See Figure 12	Full	5.5 V	-20		60	
NC, NO	I <sub>NC(ON)</sub> ,	$V_{NC}$ or $V_{NO} = 4.5 \text{ V}$ ,	Switch ON,	25°C	5.5.7	-6	2.8	4	
ON leakage current	I <sub>NO(ON)</sub>	V <sub>COM</sub> = Open,	See Figure 13	Full	5.5 V	-40		70	nA
СОМ		$V_{NC}$ or $V_{NO} = 4.5 \text{ V or Open}$ ,	Switch ON.	25°C		-4	0.47	7	
ON leakage current	I <sub>COM(ON)</sub>	$V_{COM} = 4.5 \text{ V},$	See Figure 13	Full	5.5 V	-40		80	nA
<b>Digital Control</b>	Input (IN)								
Input logic high	V <sub>IH</sub>			Full		2.4		5.5	V
Input logic low	V <sub>IL</sub>			Full		0		0.8	V
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>I</sub> = 5.5 V or 0		Full	5.5 V	-1		1	μА

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 



# **Electrical Characteristics for 5-V Supply (continued)**

 $V_{+}$  = 4.5 V to 5.5 V (5 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CO	NDITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN TYP(1)	MAX	UNIT
Dynamic								
Turn-on time	t <sub>ON</sub>	$V_{COM} = V_+,$ $R_L = 50 \Omega,$	$C_L = 35 \text{ pF},$ See Figure 15	25°C Full	4.5 V to 5.5 V	20	35 40	ns
Turn-off time	t <sub>OFF</sub>	$V_{COM} = V_+,$ $R_L = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 15	25°C Full	4.5 V to 5.5 V	15	20 35	ns
Break-before- make time	t <sub>BBM</sub>	$V_{NC} = V_{NO} = V_{+}/2,$ $R_{L} = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 16	25°C Full	4.5 V to 5.5 V	1 12 1	14.5	ns
Charge injection	$Q_{\mathbb{C}}$	C <sub>L</sub> = 1 nF, V <sub>GEN</sub> = 0 V,	See Figure 20	25°C	5 V	36		рС
NC, NO OFF capacitance	$\begin{array}{c} C_{NC(OFF)}, \\ C_{NO(OFF)} \end{array}$	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	5 V	23		pF
NC, NO ON capacitance	C <sub>NC(ON)</sub> , C <sub>NO(ON)</sub>	V <sub>NC</sub> or V <sub>NO</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	5 V	84		pF
COM ON capacitance	C <sub>COM(ON)</sub>	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	5 V	84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	5 V	2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	5 V	100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	5 V	-65		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	5 V	-65		dB
Total harmonic distortion	THD	$R_L = 600 \Omega,$ $C_L = 50 pF,$	f = 600 Hz to 20 kHz, See Figure 21	25°C	5 V	0.01		%
Supply				•				
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+} \text{ or GND},$	Switch ON or OFF	Full	5.5 V		0.1	μΑ

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# **Electrical Characteristics for 3.3-V Supply**

 $V_{+} = 3 \text{ V to } 3.6 \text{ V (3.3 V nominal)}, T_{A} = -55^{\circ}\text{C to } 125^{\circ}\text{C (unless otherwise noted)}$ 

PARAMETER	SYMBOL	TEST CONI	DITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT	
Analog Switch								<u> </u>		
Analog signal range	$V_{COM}$ , $V_{NC}$ , $V_{NO}$					0		V <sub>+</sub>	V	
Peak ON	r <sub>peak</sub>	$0 \le V_{NO} \text{ or } V_{NC} \le V_+,$	Switch ON,	25°C	3 V		1.35	2.15	Ω	
resistance	poun	$I_{COM} = -24 \text{ mA},$	See Figure 11	Full				2.15		
ON-state	r <sub>on</sub>	$V_{NO}$ or $V_{NC} = 2 V$ ,	Switch ON,	25°C	3 V		1.15	1.7	Ω	
resistance	OII	$I_{COM} = -24 \text{ mA},$	See Figure 11	Full				1.7		
ON-state resistance match between channels	$\Delta r_{\sf on}$	$V_{NO}$ or $V_{NC} = 2 \text{ V}$ , 0.8 V, $I_{COM} = -24 \text{ mA}$ ,	Switch ON, See Figure 11	25°C	3 V		0.11		Ω	
ON-state resistance	r	$0 \le V_{NO}$ or $V_{NC} \le V_+$ , $I_{COM} = -24$ mA	Switch ON,	25°C	3 V		0.225		Ω	
flatness	r <sub>on(flat)</sub>	$V_{NO}$ or $V_{NC}$ = 2 V, 0.8 V, $I_{COM}$ = -24 mA	See Figure 11	25 0			0.25			
NC, NO OFF leakage current	I <sub>NC(OFF)</sub> , I <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = 3 V$ , $V_{COM} = 0$ ,	Switch OFF, See Figure 12	25°C	3.6 V		0.2		nA	
NC, NO ON leakage current	I <sub>NC(ON)</sub> , I <sub>NO(ON)</sub>	V <sub>NC</sub> or V <sub>NO</sub> = 3 V, V <sub>COM</sub> = Open,	Switch ON, See Figure 13	25°C	3.6 V		2.8		nA	
COM ON leakage current	I <sub>COM(ON)</sub>	$V_{NC}$ or $V_{NO} = 3$ V or Open, $V_{COM} = 3$ V,	Switch ON, See Figure 13	25°C	3.6 V		0.47		nA	
Digital Control I	nput (IN)			<u> </u>						
Input logic high	V <sub>IH</sub>			Full		2		5.5	V	
Input logic low	V <sub>IL</sub>			Full		0	0.6		V	
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>I</sub> = 5.5 V or 0		Full	3.6 V	-1		1	μΑ	

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 



# **Electrical Characteristics for 3.3-V Supply (continued)**

 $V_{+} = 3 \text{ V to } 3.6 \text{ V (}3.3 \text{ V nominal)}, T_{A} = -55^{\circ}\text{C to } 125^{\circ}\text{C (unless otherwise noted)}$ 

PARAMETER	SYMBOL	TEST CON	DITIONS	TA	V <sub>+</sub>	MIN TYP(1)	MAX	UNIT
Dynamic								
Turn-on time	t <sub>ON</sub>	$V_{COM} = V_+,$ $R_1 = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 15	25°C Full	3 V to 3.6 V	30	40 55	ns
Turn-off time	t <sub>OFF</sub>	V <sub>COM</sub> = V <sub>+</sub> ,	C <sub>L</sub> = 35 pF,	25°C	3 V to 3.6 V	20	25	ns
	011	$R_L = 50 \Omega$ ,	See Figure 15	Full	3.6 V		40	
Break-before- make time	t <sub>BBM</sub>	$V_{NC} = V_{NO} = V_{+}/2,$ $R_{L} = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 16	25°C Full	3 V to 3.6 V	1 21	29	ns
Charge injection	Q <sub>C</sub>	C <sub>L</sub> = 1 nF, V <sub>GEN</sub> = 0 V,	See Figure 20	25°C	3.3 V	20		рС
NC, NO OFF capacitance	C <sub>NC(OFF)</sub> , C <sub>NO(OFF)</sub>	V <sub>NC</sub> or V <sub>NO</sub> = V <sub>+</sub> or GND, Switch OFF,	See Figure 14	25°C	3.3 V	23		pF
NC, NO ON capacitance	C <sub>NC(ON)</sub> , C <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	3.3 V	84		pF
COM ON capacitance	C <sub>COM(ON)</sub>	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	3.3 V	84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	3.3 V	2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	3.3 V	100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	3.3 V	-65		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	3.3 V	-65		dB
Total harmonic distortion	THD	$R_L = 600 \Omega,$ $C_L = 50 pF,$	f = 600 Hz to 20 kHz, See Figure 21	25°C	3.3 V	0.015		%
Supply								
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+}$ or GND,	Switch ON or OFF	Full	3.6 V		0.1	μΑ

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# **Electrical Characteristics for 2.5-V Supply**

 $V_{+}$  = 2.3 V to 2.7 V (2.5 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST COND	ITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT
Analog Switch									
Analog signal range	$V_{COM}$ , $V_{NC}$ , $V_{NO}$					0		V <sub>+</sub>	٧
Peak ON		$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,	Switch ON,	25°C	2.5 V		1.7	2.7	Ω
resistance	r <sub>peak</sub>	$I_{COM} = -8 \text{ mA},$	See Figure 11	Full	2.5 V			2.9	22
ON-state	r <sub>on</sub>	$V_{NO}$ or $V_{NC} = 1.8 \text{ V}$ ,	Switch ON,	25°C	2.5 V		1.45	2.3	Ω
resistance	on	$I_{COM} = -8 \text{ mA},$	See Figure 11	Full	2.5 V			2.5	32
ON-state resistance match between channels	$\Delta r_{\sf on}$	$V_{NO}$ or $V_{NC}$ = 0.8 V, 1.8 V, $I_{COM}$ = -8 mA,	Switch ON, See Figure 11	25°C	2.5 V		0.7		Ω
ON-state resistance	_	$0 \le V_{NO} \text{ or } V_{NC} \le V_+,$ $I_{COM} = -8 \text{ mA}$	Switch ON,	25°C	2.5 V		0.5		Ω
flatness	r <sub>on(flat)</sub>	$V_{NO}$ or $V_{NC}$ = 0.8 V, 1.8 V, $I_{COM}$ = -8 mA	See Figure 11		2.5 V		0.45		
NC, NO OFF leakage current	I <sub>NC(OFF)</sub> , I <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = 2.3 \text{ V}$ , $V_{COM} = 0$ ,	Switch OFF, See Figure 12	25°C	2.7 V		0.2		nA
NC, NO ON leakage current	I <sub>NC(ON)</sub> , I <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = 2.3 \text{ V}$ , $V_{COM} = \text{Open}$ ,	Switch ON, See Figure 13	25°C	2.7 V		2.8		nA
COM ON leakage current	I <sub>COM(ON)</sub>	$V_{NC}$ or $V_{NO}$ = 2.3 V or Open, $V_{COM}$ = 2.3 V,	Switch ON, See Figure 13	25°C	2.7 V		0.47		nA
Digital Control I	nput (IN)								
Input logic high	V <sub>IH</sub>			Full		1.8		5.5	V
Input logic low	$V_{IL}$			Full		0	0.6		٧
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>I</sub> = 5.5 V or 0		Full	2.7 V	-1		1	μΑ

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 



# **Electrical Characteristics for 2.5-V Supply (continued)**

 $V_{+}$  = 2.3 V to 2.7 V (2.5 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CON	DITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN TYP(1)	MAX	UNIT
Dynamic								
Turn-on time	+	$V_{COM} = V_+,$	C <sub>L</sub> = 35 pF,	25°C	2.3 V to	40	55	ns
rum-on ume	t <sub>ON</sub>	$R_L = 50 \Omega$ ,	See Figure 15	Full	2.7 V		70	115
Turn-off time	t <sub>OFF</sub>	$V_{COM} = V_+,$	$C_L = 35 \text{ pF},$	25°C	2.3 V to	30	40	ns
	OFF	$R_L = 50 \Omega$ ,	See Figure 15	Full	2.7 V		55	
Break-before-	t <sub>BBM</sub>	$V_{NC} = V_{NO} = V_{+}/2,$	$C_L = 35 \text{ pF},$	25°C	2.3 V to	1 33	39	ns
make time	DDIVI	$R_L = 50 \Omega$ ,	See Figure 16	Full	2.7 V	1		
Charge injection	$Q_{\mathbb{C}}$	$C_L = 1 \text{ nF},$ $V_{GEN} = 0 \text{ V},$	See Figure 20	25°C	2.5 V	13		pC
NC, NO OFF capacitance	$C_{NC(OFF)}$ , $C_{NO(OFF)}$	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	2.5 V	23		pF
NC, NO ON capacitance	$C_{NC(ON)}$ , $C_{NO(ON)}$	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	2.5 V	84		pF
COM ON capacitance	C <sub>COM(ON)</sub>	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	2.5 V	84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	2.5 V	2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	2.5 V	100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	2.5 V	-64		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	2.5 V	-64		dB
Total harmonic distortion	THD	$R_L = 600 \Omega,$ $C_L = 50 pF,$	f = 600 Hz to 20 kHz, See Figure 21	25°C	2.5 V	0.025		%
Supply							·	
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+}$ or GND,	Switch ON or OFF	Full	2.7 V		0.1	μΑ

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# **Electrical Characteristics for 1.8-V Supply**

 $V_{+}$  = 1.65 V to 1.95 V (1.8 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONI	DITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN TYP <sup>(1)</sup>	MAX	UNIT
Analog Switch								
Analog signal range	$V_{COM}$ , $V_{NC}$ , $V_{NO}$					0	V <sub>+</sub>	V
Peak ON	r .	$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,	Switch ON,	25°C	1.8 V	4	4.9	Ω
resistance	r <sub>peak</sub>	$I_{COM} = -2 \text{ mA},$	See Figure 11	Full	1.0 V	7		
ON-state	r <sub>on</sub>	$V_{NO}$ or $V_{NC} = 1.5 V$ ,	Switch ON,	25°C	1.8 V	1.7	3.2	Ω
resistance	on	$I_{COM} = -2 \text{ mA},$	See Figure 11	Full	1.0 V		4.2	
ON-state				25°C		0.7		
resistance match between channels	$\Delta r_{\sf on}$	$V_{NO}$ or $V_{NC}$ = 0.6 V, 1.5 V, $I_{COM}$ = -2 mA,	Switch ON, See Figure 11	Full	1.8 V	0.7		Ω
		$0 \le V_{NO}$ or $V_{NC} \le V_+$		25°C		1.85		
ON-state	ate $I_{COM} = -2 \text{ mA}$ Switch ON	Full	1.8 V	1.85		Ω		
resistance flatness	r <sub>on(flat)</sub>	$V_{NO}$ or $V_{NC} = 0.6 \text{ V}$ , 1.5 V,	See Figure 11	25°C	1.0 V	0.9		22
		$I_{COM} = -2 \text{ mA}$		Full		0.9		
NC, NO OFF leakage current	I <sub>NC(OFF)</sub> , I <sub>NO(OFF)</sub>	V <sub>NC</sub> or V <sub>NO</sub> = 1.65 V, V <sub>COM</sub> = 0,	Switch OFF, See Figure 12	25°C	1.95 V	0.2		nA
NC, NO ON leakage current	I <sub>NC(ON)</sub> , I <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = 1.65 \text{ V}$ , $V_{COM} = \text{Open}$ ,	Switch ON, See Figure 13	25°C	1.95 V	2.8		nA
COM ON leakage current	I <sub>COM(ON)</sub>	$V_{NC}$ or $V_{NO}$ = 1.65 V or Open, $V_{COM}$ = 1.65 V,	Switch ON, See Figure 13	25°C	1.95 V	0.47		nA
Digital Control I	nput (IN)							
Input logic high	V <sub>IH</sub>			Full		1.5	5.5	V
Input logic low	V <sub>IL</sub>			Full		0 0.6		V
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>I</sub> = 5.5 V or 0		Full	1.95 V	-1	1	μΑ

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 



# **Electrical Characteristics for 1.8-V Supply (continued)**

 $V_{+}$  = 1.65 V to 1.95 V (1.8 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CON	DITIONS	T <sub>A</sub>	٧,	MIN TYP(1)	MAX	UNIT
Dynamic	•							
Turn-on time		$V_{COM} = V_+,$	C <sub>L</sub> = 35 pF,	25°C	1.65 V to	65	70	ns
rum-on time	t <sub>ON</sub>	$R_L = 50 \Omega$ ,	See Figure 15	Full	1.95 V		95	115
Turn-off time	t	$V_{COM} = V_+,$	$C_{L} = 35 \text{ pF},$	25°C	1.65 V to	40	55	ns
rum-on ume	t <sub>OFF</sub>	$R_L = 50 \Omega$ ,	See Figure 15	Full	1.95 V		70	113
Break-before-	tonu	$V_{NC} = V_{NO} = V_{+}/2,$	$C_L = 35 pF$ ,	25°C	1.65 V to	1 60	72	ns
make time	t <sub>BBM</sub>	$R_L = 50 \Omega$ ,	See Figure 16	Full	1.95 V	0.5		113
Charge injection	$Q_{C}$	$C_L = 1 \text{ nF},$ $V_{GEN} = 0 \text{ V},$	See Figure 20	25°C	1.8 V	13		pC
NC, NO OFF capacitance	C <sub>NC(OFF)</sub> , C <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	1.8 V	23		pF
NC, NO ON capacitance	$C_{NC(ON)}, \\ C_{NO(ON)}$	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	1.8 V	84		pF
COM ON capacitance	C <sub>COM(ON)</sub>	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	1.8 V	84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	1.8 V	2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	1.8 V	100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	1.8 V	-63		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	1.8 V	-63		dB
Supply		-			'		,	
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+}$ or GND,	Switch ON or OFF	Full	1.95 V		0.1	μΑ



### **TYPICAL PERFORMANCE**

1.6

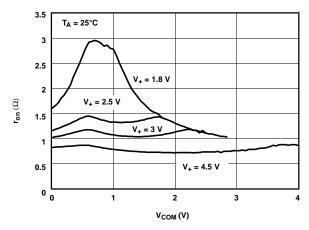
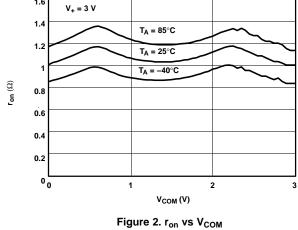


Figure 1. ron vs V<sub>COM</sub>



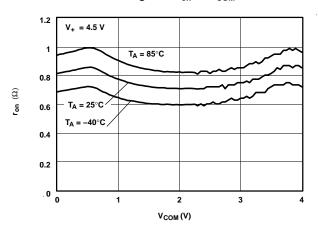


Figure 3. ron vs V<sub>COM</sub>

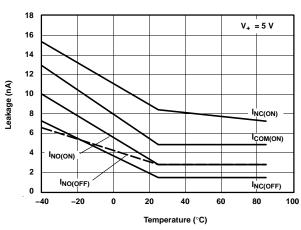


Figure 4. Leakage Current vs Temperature

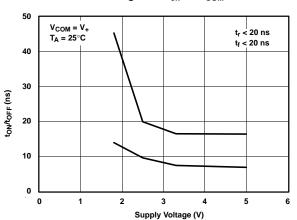


Figure 5. t<sub>ON</sub>/t<sub>OFF</sub> vs V<sub>+</sub>

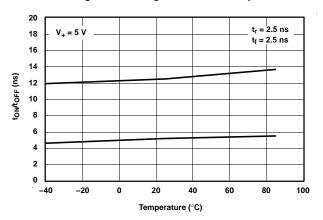
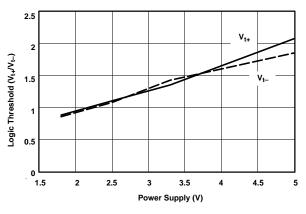


Figure 6. t<sub>ON</sub>/t<sub>OFF</sub> vs Temperature



## **TYPICAL PERFORMANCE (continued)**



-10
-20
-30
-30
-40
-5
-60
-70
-80
-90
0.1
1
10
100
1K

Frequency (MHz)

Figure 7. Logic Threshold vs Power Supply

14 V<sub>+</sub> = 5 V 12 10 Icc (nA) 6 4 2 0 -20 20 40 60 80 100 Temperature (°C)

Figure 8. Frequency Response

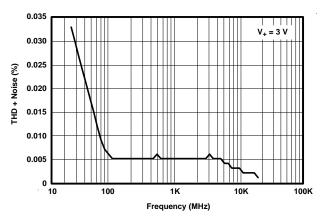


Figure 9. Power-Supply Current vs Temperature

Figure 10. Total Harmonic Distortion (THD) vs Frequency



## **PIN DESCRIPTION**

PIN NO.	NAME	DESCRIPTION				
1	NO	Normally open				
2	GND	Digital ground				
3	NC	Normally closed				
4	COM	Common				
5	V <sub>+</sub>	Power supply				
6	IN	Digital control to connect COM to NO or NC				

### **PARAMETER DESCRIPTION**

SYMBOL	DESCRIPTION
V <sub>COM</sub>	Voltage at COM
$V_{NC}$	Voltage at NC
V <sub>NO</sub>	Voltage at NO
r <sub>on</sub>	Resistance between COM and NO ports when the channel is ON
r <sub>peak</sub>	Peak on-state resistance over a specified voltage range
$\Delta r_{\sf on}$	Difference of r <sub>on</sub> between channels in a specific device
r <sub>on(flat)</sub>	Difference between the maximum and minimum value of ron in a channel over the specified range of conditions
$I_{NC(OFF)}$	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the OFF state under worst-case input and output conditions
I <sub>NO(OFF)</sub>	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the OFF state
I <sub>NC(ON)</sub>	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the ON state and the output (COM) open
I <sub>NO(ON)</sub>	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the ON state and the output (COM) open
I <sub>COM(ON)</sub>	Leakage current measured at the COM port, with the corresponding channel (COM to NO) in the ON state and the output (NO) open
$V_{IH}$	Minimum input voltage for logic high for the control input (IN)
V <sub>IL</sub>	Maximum input voltage for logic low for the control input (IN)
V <sub>IN</sub>	Voltage at IN
$I_{\rm IH},I_{\rm IL}$	Leakage current measured at IN
t <sub>ON</sub>	Turn-on time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog output (COM or NO) signal when the switch is turning ON.
t <sub>OFF</sub>	Turn-off time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog output (COM or NO) signal when the switch is turning OFF.
t <sub>BBM</sub>	Break-before-make time. This parameter is measured under the specified range of conditions and by the propagation delay between the output of two adjacent analog channels (NC and NO), when the control signal changes state.
$Q_{\mathbb{C}}$	Charge injection is a measurement of unwanted signal coupling from the control (IN) input to the analog (NO or COM) output. This is measured in coulomb (C) and measured by the total charge induced due to switching of the control input. Charge injection, $Q_C = C_L \times \Delta V_{COM}$ , $C_L$ is the load capacitance and $\Delta V_{COM}$ is the change in analog output voltage.
C <sub>NC(OFF)</sub>	Capacitance at the NC port when the corresponding channel (NC to COM) is OFF
C <sub>NO(OFF)</sub>	Capacitance at the NO port when the corresponding channel (NO to COM) is OFF
$C_{NC(ON)}$	Capacitance at the NC port when the corresponding channel (NC to COM) is ON
$C_{NO(ON)}$	Capacitance at the NO port when the corresponding channel (NO to COM) is ON
C <sub>COM(ON)</sub>	Capacitance at the COM port when the corresponding channel (COM to NO) is ON
$C_{IN}$	Capacitance of IN
O <sub>ISO</sub>	OFF isolation of the switch is a measurement of OFF-state switch impedance. This is measured in dB in a specific frequency, with the corresponding channel (NO to COM) in the OFF state.
X <sub>TALK</sub>	Crosstalk is a measurement of unwanted signal coupling from an ON channel to an adjacent ON channel (NC1 to NC2). This is measured in a specific frequency and in dB.
BW	Bandwidth of the switch. This is the frequency in which the gain of an ON channel is -3 dB below the DC gain.

# TS5A3159-EP $1-\Omega$ SPDT ANALOG SWITCH

SCDS217B-DECEMBER 2005-REVISED JANUARY 2006



## **PARAMETER DESCRIPTION (continued)**

SYMBOL	SYMBOL DESCRIPTION					
I <sub>+</sub>	I <sub>+</sub> Static power-supply current with the control (IN) pin at V <sub>+</sub> or GND					
$\Delta I_{+}$ This is the increase in I+ for each control (IN) input that is at the specified voltage, rather than at V <sub>+</sub> or GND.						



### PARAMETER MEASUREMENT INFORMATION

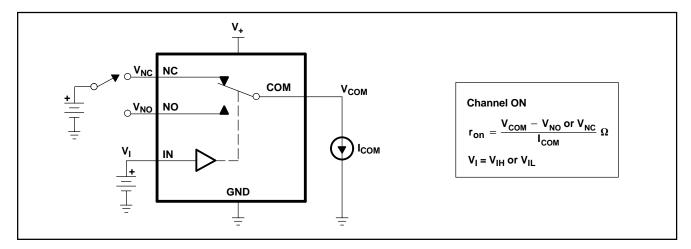


Figure 11. ON-State Resistance (ron)

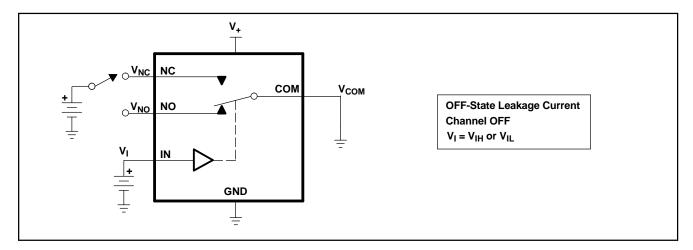


Figure 12. OFF-State Leakage Current ( $I_{NC(OFF)}$ ,  $I_{NO(OFF)}$ )

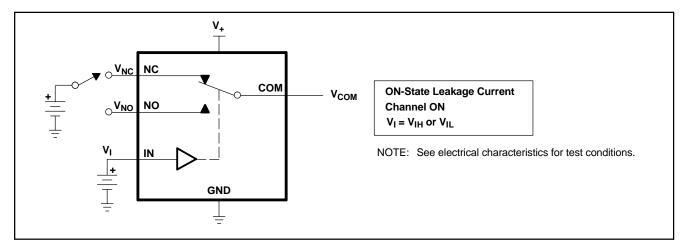


Figure 13. ON-State Leakage Current ( $I_{COM(ON)}$ ,  $I_{NC(ON)}$ ,  $I_{NO(ON)}$ )



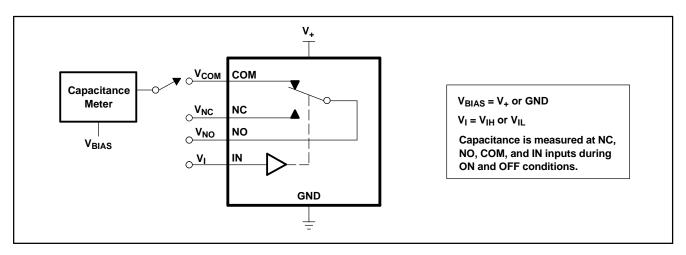
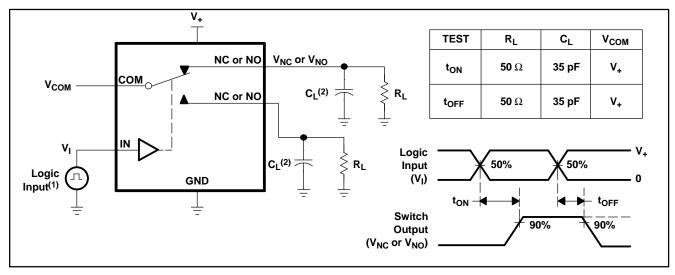


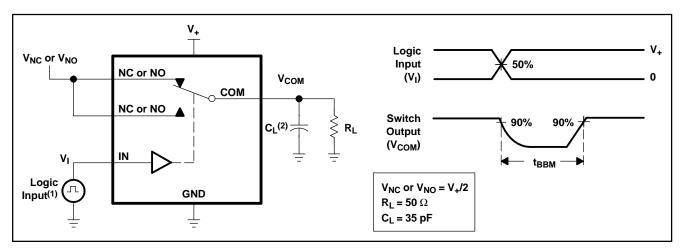
Figure 14. Capacitance (C<sub>I</sub>,  $C_{COM(ON)}$ ,  $C_{NC(OFF)}$ ,  $C_{NO(OFF)}$ ,  $C_{NC(ON)}$ ,  $C_{NO(ON)}$ )



- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r < 5 \text{ ns}$ ,  $t_f < 5 \text{ ns}$ .
- (2) C<sub>L</sub> includes probe and jig capacitance.

Figure 15. Turn-On (t<sub>ON</sub>) and Turn-Off Time (t<sub>OFF</sub>)





- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r < 5 \text{ ns}$ ,  $t_f < 5 \text{ ns}$ .
- (2) C<sub>L</sub> includes probe and jig capacitance.

Figure 16. Break-Before-Make Time (t<sub>BBM</sub>)

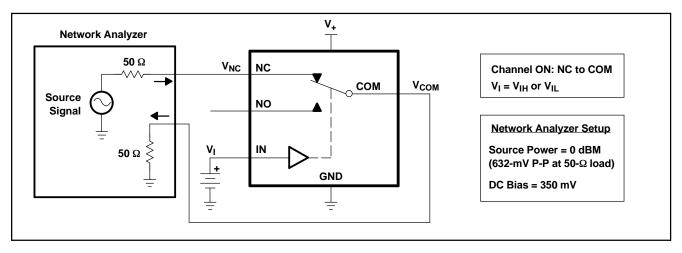


Figure 17. Bandwidth (BW)



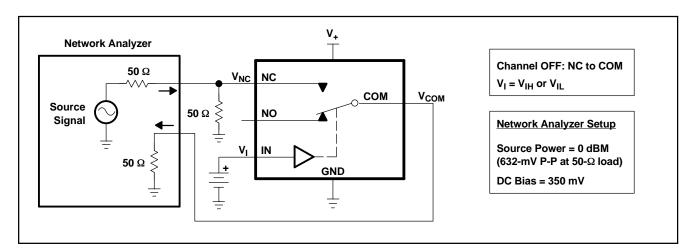


Figure 18. OFF Isolation (O<sub>ISO</sub>)

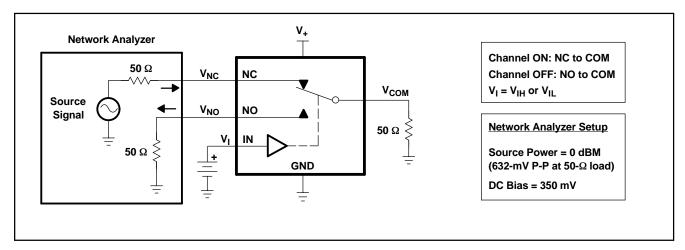
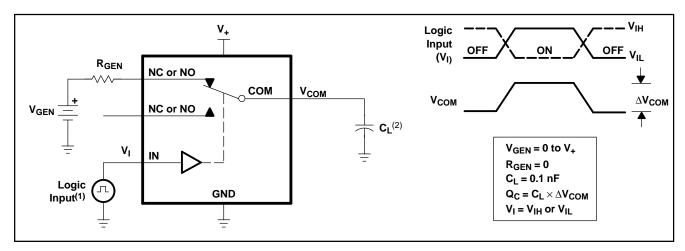


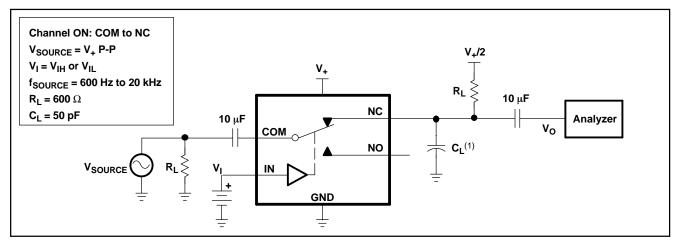
Figure 19. Crosstalk (X<sub>TALK</sub>)





- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r < 5 \text{ ns}$ ,  $t_f < 5 \text{ ns}$ .
- (2) C<sub>L</sub> includes probe and jig capacitance.

Figure 20. Charge Injection (Q<sub>C</sub>)



(1) C<sub>1</sub> includes probe and jig capacitance.

Figure 21. Total Harmonic Distortion (THD)

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### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
TS5A3159MDBVREP	Active	Production	SOT-23 (DBV)   6	3000   LARGE T&R	Yes	(4) NIPDAU	(5) Level-1-260C-UNLIM	-55 to 125	JA8R
TS5A3159MDBVREP.Z	Active	Production	SOT-23 (DBV)   6	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	JA8R
V62/06613-01XE	Active	Production	SOT-23 (DBV)   6	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	JA8R

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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#### OTHER QUALIFIED VERSIONS OF TS5A3159-EP:

Catalog: TS5A3159

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

## **PACKAGE OPTION ADDENDUM**

www.ti.com 14-May-2025

• Automotive : TS5A3159-Q1

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects

## **PACKAGE MATERIALS INFORMATION**

www.ti.com 24-Apr-2020

## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS5A3159MDBVREP	SOT-23	DBV	6	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3

www.ti.com 24-Apr-2020



### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
TS5A3159MDBVREP	SOT-23	DBV	6	3000	202.0	201.0	28.0	



SMALL OUTLINE TRANSISTOR



### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.

- 4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- 5. Refernce JEDEC MO-178.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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